 rch No	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/662,656	BARCHI ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

	SEARCHED			
Class	Subclass	Date	Examiner	
713	182	2/11/2007	ECT	
726	29	2/11/2007	ECT	
380	270	2/11/2007	ECT	
726	8	2/11/2007	ECT	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
-			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	2/11/2007	ECT
NPL - IEEE XPLORE	2/11/2007	ECT
All claims were reviewed for possible 101 rejection	2/11/2007	ECT
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